

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10/614,195	HIRAYAMA ET AL.
	Examiner	Art Unit
	Seokyun Moon	2629

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0130503	07-2004	Hamagishi et al.	345/006
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	J	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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